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**Box AF  
RESPONSE UNDER 37 CFR 1.116  
EXPEDITED PROCEDURES EXAMINING  
GROUP**

**PATENT  
1630-0455PUS1**

***IN THE U.S. PATENT AND TRADEMARK OFFICE***

Applicant:	Jong Hyeok LEE	Conf. No.:	9550
Appl. No.:	10/769,813	Group:	2627
Filed:	February 3, 2004	Examiner:	T. X. Dinh
For:	APPARATUS AND METHOD FOR DETERMINING TYPE OF OPTICAL DISK		

**REPLY UNDER 37 C.F.R. § 1.116**

**MS AF AMENDMENT**  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In response to the Examiner's Office Action dated September 18, 2007, the following remarks are respectfully submitted in connection with the above-identified application.